

AN3433 Application note

Optimization of wake-up time and power consumption on ST25R95 and CR95HF devices

Introduction

This document describes several solutions for effective management of ST25R95 and CR95HF operating states and modes in order to adapt a wakeup condition to return to the Active state, and then start communication with the external world. The main goal is power consumption reduction.

Both the ST25R95 and CR95HF devices have two main functional domains.

In the first (Active mode) the devices are able to communicate with a host using one of the serial interfaces (UART or SPI), or with RFID tags using their RF capabilities. In this mode, the device consumption is only a few mA, growing to tens of mA during RF-signal emission.

In the second domain (Wait for event mode), the devices remain quiescent while waiting for an external event. In this mode, a very low level of power consumption (only a few μA) is achieved.

The application engineer can manage the wakeup conditions to optimize wakeup time or system power consumption. This application note provides guidelines for choosing the best implementation.

January 2019 AN3433 Rev 3 1/37

Contents AN3433

Contents

1	Ref	erence information	. 6
	1.1	Reference documents	. 6
	1.2	Terms and acronyms	. 6
	1.3	Notation conventions	6
2	Mai	nagement of ST25R95 and CR95HF activity	. 8
	2.1	Overview of operating modes	. 8
	2.2	Idle command	. 9
	2.3	Idle command parameters	.11
	2.4	Using LFO frequency settings to reduce power consumption	13
	2.5	Optimizing wakeup conditions	14
		2.5.1 Wakeup source register	14
	2.6	Techniques to return to Ready state	15
		2.6.1 Default setting: from POR to Ready state	15
		2.6.2 From Ready state to Hibernate state and back to Ready state	15
		2.6.3 From Ready state to Sleep state and back to Ready state	15
	2.7	Tag detection calibration procedure	17
3	Pov	wer consumption	18
	3.1	Transition from Ready to Hibernate state	18
	3.2	Transition from Ready to Sleep state	19
	3.3	Wakeup by tag detection	20
Appendix	κA	Tag detection principle	25
	A.1	Tag detection sequence	26
Appendix	кВ	Tag detection calibration process	29
	B.1	Tag detection calibration algorithm	29
	B.2	Tag detection calibration command	30
Appendix	C	Example of tag detection calibration process	32



AN3433	Contents
AN3433	Contents

Appendix D	Example of Tag detection command using results of Tag detection calibration	35	
Revision his	tory	36	



3/37

List of tables AN3433

List of tables

Table 1.	List of terms and acronyms	. 6
Table 2.	List of characteristic values	
Table 3.	ST25R95 and CR95HF operating modes and states	. 8
Table 4.	Idle command description	
Table 5.	Idle command structure	11
Table 6.	Summary of parameters	11
Table 7.	Enter, WU, and Leave Control resource configuration	
Table 8.	Document revision history	36



AN3433 List of figures

List of figures

Figure 1.	ST25R95 and CR95HF initialization and operating state change	9
Figure 2.	Transition from Ready to Hibernate state	
Figure 3.	Wakeup from Hibernate state	
Figure 4.	Typical cycle in tag detection mode	
Figure 5.	Restart of resources in tag detection mode	
Figure 6.	RF burst in tag detection mode	
Figure 7.	Power consumption in tag detection mode	24
Figure 8.	Tag detection principle (levels of antenna current)	
Figure 9.	Time-limited tag detection sequence (display of device consumption)	
Figure 10.	Tag detection sequence, Wakeup after tag entry in operating volume	
J	(display of device consumption)	28
Figure 11	· • • • • • • • • • • • • • • • • • • •	



AN3433 Rev 3 5/37

Reference information AN3433

1 Reference information

1.1 Reference documents

CR95HF: "13.56 MHz multi-protocol contactless transceiver IC with SPI and UART serial access" datasheet, available on *www.st.com*.

ST25R95: "Near field communication transceiver" datasheet, available on www.st.com.

1.2 Terms and acronyms

Table 1. List of terms and acronyms

Term	Meaning			
AFE	Analog front end			
DAC	Digital-to-analog converter			
DFT	Design for testability			
NVM	Non-volatile memory			
RFID	Radio frequency identification			
RFU	Reserved for future use			
WFE	Wait for event			

1.3 Notation conventions

The following symbols correspond to:

>>>: Frame sent by the host to the device

<<<: Frame sent by the device to the host

Table 2. List of characteristic values

Symbol	Definition	Value			
CalRef	Tag calibration reference level and DAC threshold level for device setup	-			
DacDataH	High level detection limit	-			
DacDataL	Low level detection limit -				
MaxSleep	Number of inactivity periods (t _{INACTIVE}) before a timeout.				
SwingCnt	Number of 13.56 MHz periods in the RF burst -				
t _{DAC}	DAC set up time	-			
t _{HFO}	Period of RF carrier (13.56 MHz)	73 ns			
t _{INACTIVE}	Inactivity period, delay between two wakeups for RF burst emissions in a tag detection sequence	t _{INACTIVE} = (WuPeriod+1) * t _{REF}			
t _{LFO}	Period of device low frequency oscillator (32 kHz)	31.25 µs			



AN3433 Reference information

Table 2. List of characteristic values (continued)

Symbol	Definition	Value			
		Depends upon LFO prescaler			
		– 31.25 µs (32 kHz)			
T_L	Low frequency period	– 62.50 μs (16 kHz)			
		– 125 μs (8 kHz)			
		– 250 μs (4 kHz)			
tosc	Oscillator set-up time	-			
t _{REF}	Reference time	t _{REF} = 256 T _L			
t _{SWING}	RF Burst duration in Tag detection t_{SWING} = SwingCnt * t_{HFO}				
t _{TO}	Timeout delay after which the device will automatically leave WFE mode.	t _{TO} = (MaxSleep + 1) * t _{INACTIVE}			
WuPeriod	Number of reference times (RTs) in an inactivity period (t _{INACTIVE})	-			

2 Management of ST25R95 and CR95HF activity

2.1 Overview of operating modes

The ST25R95 and CR95HF have two operating modes, namely Wait for event and Active:

- in Active mode, the device communicates actively with a tag or with an external host (MCU)
- WFE mode includes four low consumption states: Power-up, Hibernate, Sleep and Tag detector.

The devices can switch from one mode to another.

Table 3. ST25R95 and CR95HF operating modes and states

Mode	State	Description
Wait for event (WFE)	Power-up	This mode is accessible directly after POR. Low level on IRQ_IN pin (longer than 10 µs) is the only wakeup source. LFO (low-frequency oscillator) is running in this state.
	Hibernate	Lowest power consumption state. The device has to be woken-up to communicate. Low level on $\overline{IRQ_IN}$ pin (longer than 10 μ s) is the only wakeup source.
	Sleep	Low power consumption state. Wakeup source is configurable: - Timer - IRQ_IN pin - SPI_SS pin LFO (low-frequency oscillator) is running in this state.
	Tag detector	Low power consumption state with tag detection. Wakeup source is configurable: - Timer - IRQ_IN pin - SPI_SS pin - Tag detector LFO (low-frequency oscillator) is running in this state.
Active	Ready	In this mode, the RF is OFF and the device waits for a command (e.g. PROTOCOLSELECT) from the external host via the selected serial interface (SPI).
	Reader	The device communicates with a tag using the selected protocol or with an external host using the SPI interface.

Hibernate, Sleep and Tag detector states can only be activated by a command from the external host. As soon as one of these three states is activated, the device can no longer communicate with the external host, can only be woken up.

The behavior of the device in Tag detector state is defined by the Idle command.



8/37 AN3433 Rev 3

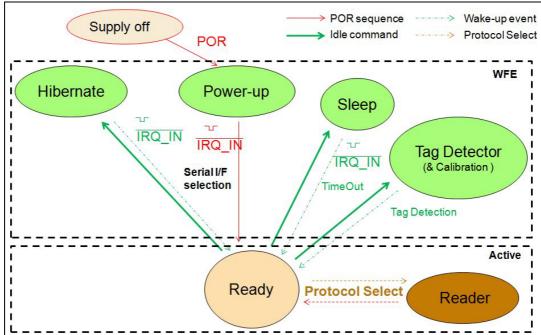


Figure 1. ST25R95 and CR95HF initialization and operating state change

2.2 Idle command

The Idle command switches the device into WFE mode (low consumption) and defines the way it returns to Ready state.

In WFE mode, the device has two low consumption states, namely Hibernate and Sleep/Tag detector.

In Hibernate state, the device power consumption is extremely low (a few μ A) because most of its resources are switched off. When it receives an external event (pin IRQ_IN), it will return to Ready mode in a few milliseconds.

In Sleep/Tag detector state, the device power consumption is low (tens of μA), and depends upon the selected wakeup source. The wakeup source can be an internal timer, an external interrupt or the presence of a tag detected by the device.

In Tag detector state, after executing an initial Tag detection calibration procedure to set-up the device, the application engineer must adjust command parameters to select the best trade-off between the wakeup delay and the power consumption.

AN3433 Rev 3 9/37

Table 4. Idle command description

Dina -4!	Data					
Direction	Data	Comments	Examples			
	07	Command code	Switch from Active mode to			
	0E	Length of data	Hibernate state: >>>0x07 0E 08 04 00			
	<wu source=""></wu>	Specifies authorized wakeup sources and the LFO frequency	04 00 18 00 00 00 00 00 00 00 00			
	EnterCtrlL	Settings to enter WFE mode	Switch from Active to WFE			
	EnterCtrlH	Settings to enter WFE mode	mode (wakeup by low pulse on IRQ IN pin):			
	WUCtrlL	Settings to wake up from WFE	>>>0x07 0E 08 01 00			
	WUCtrlH	mode	38 00 18 00 00 00 00			
	LeaveCtrlL	Settings to leave WFE mode	00 00 00 00 Switch from Active to MEE			
	LeaveCtrlH	(default value = 0x1800)	 Switch from Active to WFE mode (wakeup by low pulse 			
	<wuperiod></wuperiod>	Period of time between two tag detection bursts. Also used to specify the duration before timeout.	on SPI_SS pin): >>>0x07 0E 10 01 00 38 00 18 00 00 00 00 00 00 00 00			
	<0scStart>	Defines the Wait time for HFO to stabilize: <0scStart> * t _L (Default value = 0x60)	– Wakeup by timeout (7 s): Duration before Timeout = 256 * t _L * (WU period + 2) * (MaxSleep + 1)			
Host to device	<dacstart></dacstart>	Defines the Wait time for DAC to stabilize: <dacstart> * t_L (default value = 0x60)</dacstart>	>>>0x07 0E 01 21 00 38 00 18 00 60 60 00 00 00 00 08			
	<dacdatal></dacdatal>	Lower compare value for tag detection ⁽¹⁾ . This value must be set to 0x00 during Tag detection calibration.	 Switch from Active to Tag detector mode (wakeup by tag detection or low pulse on IRQ_IN pin) (32 kHz, 			
	<dacdatah></dacdatah>	Higher compare value for tag detection ⁽¹⁾ . This is a variable used during Tag detection calibration.	inactivity duration = 272 ms, DAC oscillator = 3 ms, Swing = 63 pulses of 13.56 MHz), 0A = Infinite sequence, 0B = Until			
	<swingscnt></swingscnt>	Number of swings HF during tag detection (default value = 0x3F)	TimeOut: >>>0x07 0E 0A 21 00			
	<maxsleep></maxsleep>	Maximum number of tag detection trials before timeout ⁽¹⁾ . This value must be set to 0x01 during Tag detection calibration.	79 01 18 00 20 60 60 64 74 3F 08 - Basic Idle command used during the Tag detection calibration process: >>>0x07 0E 03 A1 00			
		0x00 < MaxSleep < 0x1F Also used to specify duration before timeout.	F8 01 18 00 20 60 60 00 xx 3F 01, where xx is the DacDataH value.			



Direction	Data	Comments	Examples		
	0x00	Result code	This response is sent only		
	0x01	Length of data	when the device exits WFE mode.		
Device to host			<<<0x000101 Wakeup by timeout		
	<data></data>	Data (Wakeup source)	<<0x000102 Wakeup by tag detect		
			<<<0x00010 <u>8</u> Wakeup by low pulse on IRQ_IN pin		
	0x82	Error code	<<<0x8200 Invalid command		
	0x00	Length of data	length		

Table 4. Idle command description (continued)

2.3 Idle command parameters

The Idle command (Host to device) has the following structure (all values are hexadecimal):

Table 5. Idle command structure

07	0E	xx	yy zz	yy zz	yy zz	aa	bb	CC	dd ee	ff	gg
Command code	Data	WU	Enter	WU	Leave	WU	Osc	DAC	DAC	Swing	Max
	length	source	Control	Control	Control	Period	Start	Start	Data	Count	Sleep

Table 6. Summary of parameters

Parameter	Description		
Command code	This byte is the command code. '07' represents the Idle command. This command switches the device from Active to WFE mode.		
Data length	This byte is the length of the command in bytes. Its value depends on the following parameter values.		
	7:6	LFO prescaler: - 00: 1 (f _{LFO} = 32 kHz) - 01: 2 (f _{LFO} = 16 kHz) - 10: 4 (f _{LFO} = 8 kHz) - 11: 8 (f _{LFO} = 4 kHz)	
WU Source	5	RFU	
WO Source	4	Wake-up source: Low pulse on SPI_SS	
	3	Wake-up source: Low pulse on IRQ_IN	
	2	Wake-up source: Field detection	
	1	Wake-up sources: Tag detection	
	0	Wake-up sources: Timeout	



AN3433 Rev 3 11/37

An initial calibration is necessary to determine DacDataL and DacDataH values required for leaving Tag detector state. For more information, contact your ST sales office for the corresponding application note.

Table 6. Summary of parameters (continued)

Parameter	Description	
Enter Control	These two bytes (EnterCtrlL and EnterCtrlH) define the resources when entering WFE mode (see <i>Table 7</i>): - 0x0400: Hibernate - 0x0100: Sleep (or 0x2100 if Timer source is enabled) - 0x0142: Sleep (if Field detector source is enabled) - 0xA200: Tag detector calibration - 0x2100: Tag detection	
WU Control	These two bytes (WuCtrlL and WuCtrlH) define the wakeup resources (see Table 7): - 0x0400: Hibernate - 0x3800: Sleep / Field detector - 0xB801: Tag detector calibration - 0x3801: Tag detection	
Leave Control	These two bytes (LeaveCtrlL and LeaveCtrlH) define the resources when returning to Ready state (see <i>Table 7</i>): - 0x1800: Hibernate - 0x1800: Sleep - 0x1800: Tag detector calibration - 0x1800: Tag detection	
WU Period	This byte is the coefficient used to adjust the allowed time between two tag detections. Also used to specify the duration before timeout (typical value: 0x20). Duration before Timeout = $256 * t_L * (WU period + 2) * (MaxSleep + 1)$	
Osc Start	This byte defines the delay for HFO stabilization (recommended value: 0x60). Defines the Wait time for HFO to stabilize: <oscstart> * t_L</oscstart>	
DAC Start	This byte defines the delay for DAC stabilization (recommended value: 0x60). Defines the Wait time for DAC to stabilize: <dacstart> * t_L</dacstart>	
DAC Data	These two bytes (DacDataL and DacDataH) define the lower and higher comparator values, respectively. These values are determined by a calibration process. When using the device demonstration board, these values must be set to approximately 0x64 and 0x74, respectively.	
Swing Count	This byte defines the number of HF swings allowed during tag detection (recommended value: 0x3F).	
Max Sleep	This byte defines the maximum number of tag detection trials or the coefficient to adjust the maximum inactivity duration before timeout. – Must be 0x00 < MaxSleep < 0x1F – Must be set to 0x01 during the Tag detection calibration process Also used to specify duration before timeout: 256 * t _L * (WU period + 2) * (MaxSleep + 1), typical value: 0x28.	



Table 7. Enter, WU, and Leave Control resource configuration

Byte	Bit(s)	Function	Comments
CtIrL (byte YY)	7:2	RFU	Must be set to 0.
	1	Field detector disabled - 0 = Field detector disabled - 1 = Field detector enabled	-
	0	IREF - 0 = IREF disabled - 1 = IREF enabled	Must to be set to 1 in WUCtrLI for tag detection operation, otherwise must be put to 0.
	7	DAC compare index for the first comparison - 0 = DacDataL - 1 = DacDataH	-
	6	RFU	Must be set to 0.
CtlrH (byte ZZ)	5	LFO enable - 0 = LFO disabled - 1 = LFO enabled	Must be set to 1 in WUCtrlH.
	4	HFO enable - 0 = HFO disabled - 1 = HFO enabled	Must be set to 1 in WUCtrll.
	3	VDDA enable - 0 = VDDA disabled - 1 = VDDA enabled	Must be set to use HFO.
	2	Hibernate state enable - 0 = Hibernate state disabled - 1 = Hibernate state enabled	-
	1	RFU	-
	0	Sleep state enable - 0 = Sleep state disabled - 1 = Sleep state enabled	-

2.4 Using LFO frequency settings to reduce power consumption

In WFE mode, the high frequency oscillator (HFO) is stopped and most processes in execution are clocked by the low frequency oscillator (LFO). The slower the LFO frequency, the lower the power consumption.

Example 1: Setting a lower LFO frequency

The following equation defines a basic timing reference:

 t_{REF} = 256 * t_{L} ms (where t_{L} = 1 / f_{LFO})

 t_{REF} = 8 ms (when <WU Source> bits [7:6] are set to '00', or 32 kHz)

 t_{REF} = 64 ms (when <WU Source> bits [7:6] are set to '11', or 4 kHz)



AN3433 Rev 3 13/37

2.5 Optimizing wakeup conditions

Using the Wakeup source register, it is possible to cumulate sources for a wakeup event. It is strongly recommended to always set an external event as a possible wakeup source.

To cumulate wakeup sources, simply set the corresponding bits in the wakeup source register. For example, to enable a wakeup when a tag is detected (bit 1 set to '1') or on a low pulse on pin IRQ_IN (bit 3 set to '1'), set the register to 0x0A.

2.5.1 Wakeup source register

Wakeup conditions are defined in the 8-bit wakeup condition register. These bits select one or several external conditions to be evaluated by the device in order to exit Idle mode.

Bit 0: When set, the device will wake up and return to Ready state at the end of a predefined cycle. The timeout (TO) value is defined by the Max sleep and Wake Up period.

This bit must be set when using the timer as a possible wakeup source. It must be set during Tag detection calibration to force a wakeup after the first tag detection trial.

Bit 1: When set, the device will wake up when a Tag is detected in the RF field. This bit must also be set during Tag detection calibration or during tag detection (when the RF field is active).

Bit 2: When set, the device will wake up when an the presence of the field is detected.

Bit 3: When set, the device will wake up when an external interrupt (low level on pin IRQ IN) is detected. This is useful for SPI communications.

It is recommended to set this bit to '1' in order to recover in the event of a system crash.

Bit 4: When set, the device will wake up when an external interrupt (low level on pin |SPI_SS) is detected. This is useful for UART communication.

Bit 5: RFU

Bits [6:7]: LFO prescaler.

Cumulation of wakeup conditions

The wakeup conditions selected in the Wakeup condition register can be cumulated.

When the device returns to Ready state, it is possible to use the Read register (RdReg) command to read the Wakeup condition register to know which event caused the device to wake up from Idle mode.

Read Wakeup condition register: 08 03 62 01 00

Reply ('xx' represent the Wakeup condition register bits): 00 01 xx

This information is used after each iteration during the Tag detection calibration process to determine the CalRef level. This level corresponds to the switching of the bits in the Wakeup condition register from 0x02 (Tag detector) to 0x01 (Timeout) when using the device previously calibrated in a free-air environment (no tags present).



2.6 Techniques to return to Ready state

The Idle command and reply set offers several benefits to users by enabling various methods to return the device to Ready state. Some methods are nearly automatic, such as waiting for a timer overflow or a tag detection, but others consume more power compared to those requesting a host action. A description of each method is given in the following subsections.

2.6.1 Default setting: from POR to Ready state

After power-on, the device enters Power-up state.

To wake up the device and set it to Ready state, the user must send a low pulse on the IRQ_IN pin. The device then automatically selects the external interface (SPI or UART) and enters Ready state and is able to accept commands after a delay of approximately 3 ms.

2.6.2 From Ready state to Hibernate state and back to Ready state

In Hibernate state, most resources are switched off to achieve an ultra-low power consumption.

The only way the device can wake up from Hibernate state is by an external event (low pulse on pin IRQ_IN).

A basic Idle command is:

```
>>>0x07 0E 08 04 00 04 00 18 00 00 00 00 00 00 00 00
```

Note:

The Wakeup flag value is not significant when returning to Ready state from Hibernate state or after a POR.

2.6.3 From Ready state to Sleep state and back to Ready state

Wake up by external event (low pulse on IRQ IN or SPI SS pin)

In Sleep or Power-up states, operating resources are limited in function of the selected wakeup source to achieve a moderate power consumption level.

An Idle command example when wakeup source is pin \overline{IRQ} IN:

```
>>>0x07 0E 08 01 00 38 00 18 00 00 60 00 00 00 00 00
```

A similar command can be implemented using pin SPI_SS as a wakeup source:

```
>>>0x07 0E 10 01 00 38 00 18 00 00 60 00 00 00 00 00
```

Wakeup by Timeout

The LFO is required to use the timer. However, this increases the typical power consumption by 80 µA. Several parameters can be modified to minimize this parameter.

The Duration before timeout is defined by parameters WU period and MaxSleep, respectively 0x60 and 0x08 in the following example.

Duration before timeout = 256 * t_l * (WU period + 2) * (MaxSleep + 1)

Note: 0x00 < MaxSleep < 0x1F.

An Idle command example when wakeup source is timer (0x01) when f_{LFO} = 32 kHz (mean power consumption is 25 μ A)

>>>0x07 0E 01 21 00 38 00 18 00 60 60 00 00 00 00 08



AN3433 Rev 3 15/37

An Idle command example when wakeup source is timer (0xC1) when f_{LFO} = 4 kHz (mean power consumption is 20 μ A):

```
>>>0x07 0E C1 21 00 38 00 18 00 60 60 00 00 00 00 08
```

The same command can be used mixing a timer and the IRQ_IN pin (0xC9) as a wakeup source:

```
>>>0x07 0E C9 21 00 38 00 18 00 60 60 00 00 00 00 08
```

Wakeup by tag detection

In this mode, the typical consumption can greatly vary in function of parameter settings (WU period without RF activity and swing count defining the RF burst duration). Using default settings, consumption in the range of 100 μ A can be achieved.

Tag detector is a state where the devices are able to detect an RF event and a wakeup will occur when a tag sufficiently modifies the antenna load and is detected by the device.

An Idle command example when wakeup source is tag detection (0x02):

```
>>>0x07 0E 02 21 00 79 01 18 00 20 60 60 64 74 3F 08
```

The same command can be used mixing tag detection and the IRQ_IN pin (0x0A) as a wakeup source:

```
>>>0x07 0E 0A 21 00 79 01 18 00 20 60 60 64 74 3F 08
```

The tag detection sequence is defined by dedicated parameters:

- WU source (byte 3)
 - The Timeout bit (bit 0) must be set to '1' in order to manage a certain number of emitted bursts. Otherwise, bursts will be sent indefinitely until a stop event occurs (for example, tag detection or a low pulse on pin IRQ IN).
 - The Tag Detect bit (bit 1) must be set to '1' to enable RF burst emissions.
 - It is recommended to also set Bits 3 or 4 to '1' to ensure that it is possible to leave Tag Detect mode via an external event (for example, a low pulse on pin IRQ_IN).
- WU period (byte 10): Defines the period of inactivity (t_{INACTIVE}) between two RF bursts:

```
t_{INACTIVE} = (WuPeriod + 2) * t_{REF}
```

 OscStart, DacStart (bytes 11 and 12): Define the set-up time of the HFO and of the DAC, respectively. In general, 3 ms is used both set-up times.

```
HFO | DAC set-up time = (OscStart | DacStart) * t<sub>L</sub>
```

- DacDataL, DacDataH (bytes 13 and 14): Reference level for tag detection (calculated during the tag detection calibration process).
- SwingsCnt (byte 15): Represents the number of 13.56-MHz swings allowed during a tag detection burst. It is recommended to use 0x3F.
- MaxSleep (byte 16): The device emits (MaxSleep +1) bursts before leaving tag detection mode if bit 0 (Timer out) of the WU source register is set to '1'. Otherwise, when this bit is set to '0', a burst is emitted indefinitely.

Note: Bytes 4 to 9 have to be used as shown in the examples in Section 2.3.

Note: MaxSleep value is coded on the five least significant bits, hence 0x00 < MaxSleep < 0x1F.

All the previously described command parameters must be chosen accordingly for the initial tag detection calibration when setting up the ST25R95 and CR95HF devices.

577

16/37 AN3433 Rev 3

Their value will impact tag detection efficiency and power consumption during tag detection periods.

2.7 Tag detection calibration procedure

The Idle command makes it possible to use the tag detection as a wakeup event.

Some parameters of the Idle command are dedicated to setting the conditions of a tag detection sequence.

During the tag detection sequence, the ST25R95 and CR95HF regularly emit RF bursts and measure the current in the antenna driver I_{DRIVE} using the internal 6-bit DAC.

When a tag enters the device antenna RF operating volume, it modifies the antenna loading characteristics and induces a change in I_{DRIVE} , and consequently, the DAC data register reports a new value.

This value is then compared to the reference value established during the tag detection calibration process. This enables the device to decide if a tag has entered or not its operating volume.

The reference value (DacDataRef) is established during a tag detection calibration process using the device application setting with no tag in its environment.

The calibration process consists in executing a tag detection sequence using a well-known configuration, with no tag within the antenna RF operating volume, to determine a specific reference value (DacDataRef) that will be reused by the host to define the tag detection parameters (DacDataL and DacDataH).

During the calibration process, DacDataL is forced to 0x00 and the software successively varies the DacDataH value from its maximum value (0xFE) to its minimum value (0x00). At the end of the calibration process, DacDataRef will correspond to the value of DacDataH for which the wakeup event switches from timeout (no tag in the RF field) to tag detected.

To avoid too much sensitivity of the tag detection process, it is recommended to use a guard band. This value corresponds to two DAC steps (0x08).

Recommended guard band value:

DacDataL = DacDataRef - Guard and DacDataH = DacDataRef + Guard

The parameters used to define the tag detection calibration sequence (clocking, set-up time, burst duration, etc.) must be the same as those used for the future tag detection sequences.

When executing a tag detection sequence, the device compares the DAC data register value to the DAC data parameter values (DacDataL and DacDataH) included in the Idle command. The device will exit WFE mode through a tag detection event if the DAC data register value is greater than the DAC data parameter high value (DacDataH) or less than the DAC data parameter low value (DacDataL). Otherwise, it will return to Ready state after a timeout.

An efficient 8-step calibration algorithm is described in *Appendix C*.

An example of a basic Idle command used during the Tag detection calibration process:

>>>0x07 0E 03 A1 00 F8 01 18 00 20 60 60 00 xx 3F 01

where xx is the DacDataH value.

An example of a tag detection sequence is provided in *Appendix D*.



AN3433 Rev 3 17/37

Power consumption AN3433

3 Power consumption

This section describes the advantages and benefits of using the various Idle command parameters to select the best wakeup configuration for your device, to ensure optimal power consumption for the application.

In the previous section it has been detailed how to use the Idle command to set the device from Ready to one of the three WFE modes (Hibernate, Sleep, and Tag detector). The following sections describe the various wakeup processes for the selected WFE mode.

3.1 Transition from Ready to Hibernate state

Hibernate state consumes the minimum amount of power of all the possible device states.

Only an Idle command can set the device from Ready state to Hibernate state. After receiving the Hibernate command via the SPI bus, the device stops the oscillator and the analog resources and enters Hibernate state. in *Figure 2* yellow represents the 27.12 MHz (HFO) oscillator, the SPI_SCK signal is in green.

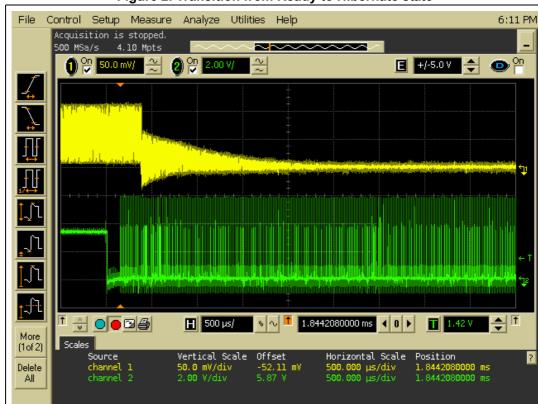


Figure 2. Transition from Ready to Hibernate state

A basic Idle command to set the device from Ready state to Hibernate state is:

>>> 0x07 0E 08 04 00 04 00 18 00 00 00 00 00 00 00 00



AN3433 Power consumption

In Hibernate state, the device minimizes its power consumption by disabling most of its resources before stopping the external oscillator. In this state, power consumption will decrease from approximately 2.5 mA to less than 2 μ A.

The device can only wakeup from Hibernate state by means of an external event (pin IRQ_IN goes low).

The device will only send its response after having returned to Ready state after an external event is detected.

When the device wakes up from Hibernate state (*Figure 3*), it restarts the external oscillator and all other resources, including the selected communication interface, before returning to Ready state and waiting for a new command. *Figure 3* shows the device waking up from Hibernate state when pin IRQ_IN (green) goes low. When the device returns to Ready state, the HF oscillator (yellow) restarts the analog blocks.

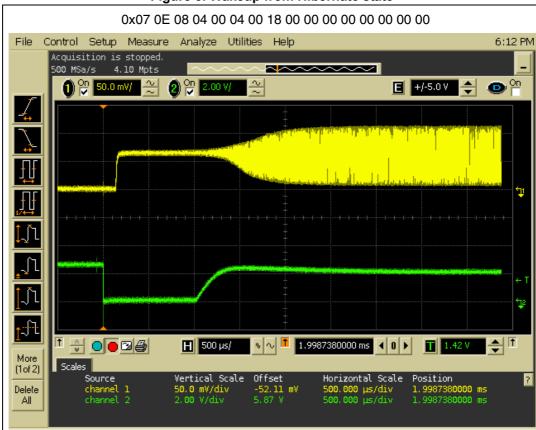


Figure 3. Wakeup from Hibernate state

3.2 Transition from Ready to Sleep state

This transition ensures low power consumption as well as a fast recovery (switch to Ready state).

When the device receives an Idle command with the Sleep option, it only partially disables its resources. In this state, power consumption will decrease from 2.5 mA to approximately $20~\mu A$.



AN3433 Rev 3 19/37

Power consumption AN3433

The device can wake up from Idle state only at the end of pre-defined timeout or by an external event (pin IRQ_IN or SPI_SS goes low).

A basic Idle command used to wake up the device at the end of pre-defined timeout is:

```
>>> 0x07 0E 01 01 00 38 00 18 00 60 00 00 00 00 00 00
```

In this example, the timer uses only the LF oscillator. The timeout period is defined as:

```
TO = 256 * t<sub>1</sub> * (WuPeriod + 2) * (MaxSleep + 1)
```

A basic Idle command used to wake up the device by an external event (pin IRQ_IN) is:

```
>>> 0x07 0E 08 01 00 38 00 18 00 60 00 00 00 00 00 00
```

A basic Idle command used to wake up the device by an external event (pin SPI_SS) is:

```
>>> 0x07 0E 10 01 00 38 00 18 00 60 00 00 00 00 00 00
```

The device will only send its response after having returned to Ready state after an external event is detected.

When the device wakes up from Sleep state, it restarts the external oscillator and all other resources, including the selected communication interface, before returning to Ready state and waiting for a new command.

In certain cases (mainly when using the UART), it may be necessary to use an Echo command to re-synchronize the host and the device.

3.3 Wakeup by tag detection

The tag detection process requires the temporary use of internal resources (e.g. the 13.56 MHz HF oscillator) usually switched off in WFE mode and only turned on during an RF burst emission to determine if a tag entered the device operating range.

The delay (t_{INACTIVE}) between two RF burst emissions is defined in the Idle command by the WuPeriod parameter.

For a complete description of the tag detection process, see *Appendix A*.

$$t_{INACTIVE} = (WuPeriod + 1) * t_{REF}$$

In the example shown in Figure 4

$$t_{INACTIVE} = (32 + 1) * 8 ms = 264 ms$$

Figure 5 is a zoomed image of *Figure 4* including the HFO stabilization time (OscStart) and the DAC initialization time (DacStart).

Note:

In figures 4 to 7 yellow is for the 27.12-MHz (HFO) oscillator, the RF emission is in green.

The duration of the RF burst (t_{SWING}) is defined by SwingsCnt, the number of 13.56-MHz pulses emitted. This value must be adjusted initially in the application environment to obtain the best measurement stability.

$$t_{SWING}$$
 = SwingsCnt * t_{HFO} = 64 * 73 ns = 4.5 μ s

Increasing the SwingsCnt value improves the DAC accuracy, but also increases the power consumption of the RF drivers (pin VPS_TX).

4

AN3433 Power consumption

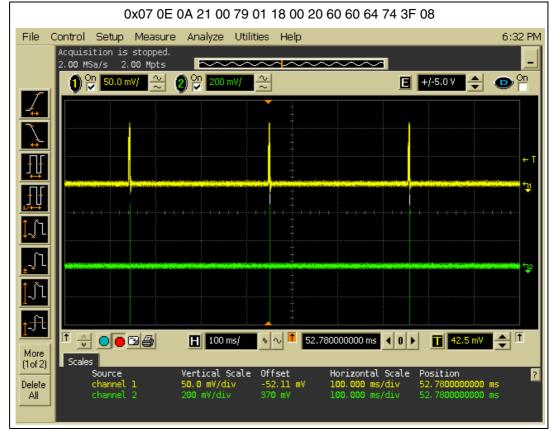


Figure 4. Typical cycle in tag detection mode



AN3433 Rev 3 21/37

Power consumption AN3433

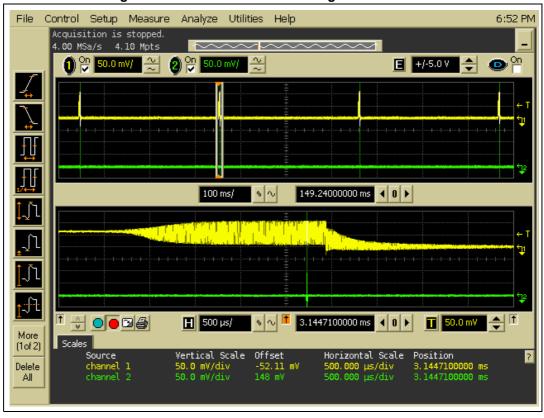


Figure 5. Restart of resources in tag detection mode



When using the device demonstration board, it is recommended a SwingsCnt value of 0x3F, corresponding to 64 RF pulses per burst (in blue) for a duration of 4.7 μ s, as shown in *Figure 6*. This results in a mean power consumption of 100 μ A.

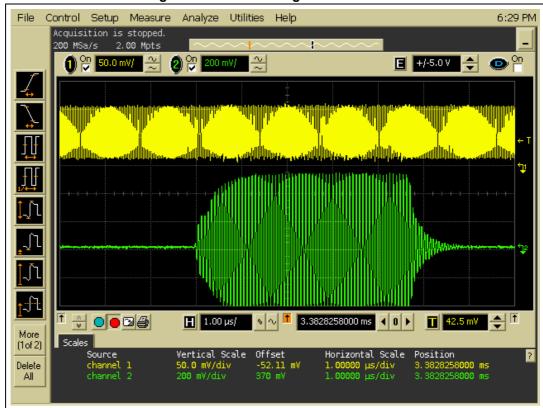


Figure 6. RF burst in tag detection mode



AN3433 Rev 3 23/37

Power consumption AN3433

The device consumes the most power during RF emissions in tag detection mode (*Figure 7*). The user can regulate the mean consumption by modifying the period between bursts (WuPeriod).

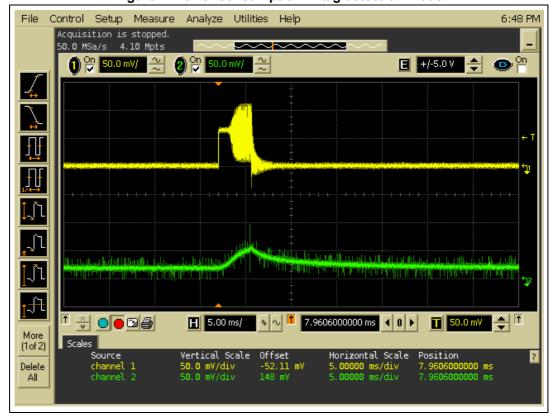


Figure 7. Power consumption in tag detection mode



Appendix A Tag detection principle

The tag detection process requires the temporary use of internal resources (such as the 13.56 MHz HF oscillator or the DAC) that are usually switched off in WFE mode and only turned on during an RF burst emission to determine if tag entered the device operating range.

To detect the presence of a tag, the device measures a portion of the device antenna current using the DAC (DacLevel) and compares this value to a reference value (CalRef) determined in the same way when the application is initialized.

To do this, once the HF oscillator is stabilized, the device emits an RF burst and monitors its antenna current using its internal 64-bit DAC. This result is then compared to a reference value established during the Tag detection calibration phase.

The device is initially calibrated by the user application in a free-air environment (no tags present) in order to obtain a reference value (CalRef) that corresponds to the basic threshold of its comparator.

A new measurement of the antenna current with a value different (see *Figure 8*) from the CalRef value indicates that a tag is (most likely) present in the RF field.

To reduce the margin of error for false detections, in addition to comparing the value of the measured antenna current (DacLevel) to the reference value (CalRef), the device checks that the measured value is within a given range:

DacDataL < DacLevel < DacDataH

Using range limits ensures a stable Tag Detection process. Usually:

DacDataL = CalRef - 0x08 and DacDataH = CalRef + 0x08

The parameters that define measurement resources (oscillator and DAC setup times or RF burst duration) can be individually adjusted within the Idle command parameters, but they must remain unchanged between the calibration and tag detection periods.

For the HF oscillator and DAC stabilization times (OscStart and DacStart, respectively) It is recommended a minimum value of 0x60, corresponding to a duration of 3 ms (96 * t_{LFO}).

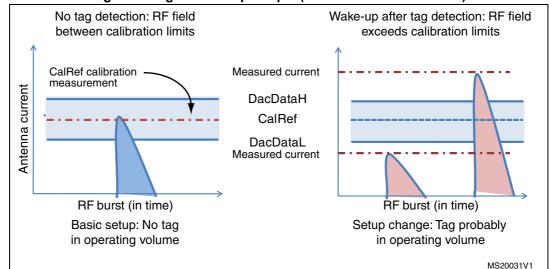


Figure 8. Tag detection principle (levels of antenna current)

AN3433 Rev 3 25/37

A.1 Tag detection sequence

Several parameters of the tag detection sequence can be managed to optimize the wakeup time or power budget.

By adjusting the inactivity time (t_{INACTIVE}), the time between two tag detection RF bursts, the power consumption can be modified through the WuPeriod parameter in the Idle command (usually set to 0x20).

The user can choose to limit number of tag detection trials by adjusting the MaxSleep value. This MaxSleep value is validated only when the correct Wakeup condition is set (Bit 0 of the Wakeup condition register). Otherwise, the tag detection sequence is repeated continuously until a wakeup event occurs.

A minimum duration of 3 ms must be set for the DAC and HFO setup times to obtain a good measurement accuracy. This phase is a high consumption period, so it is recommended to keep it short. The setup times (DacStart and OscStart, respectively) are defined in the Idle command and are both usually set to 0x60.

The RF burst length (SwingCnt) corresponds to the acquisition time necessary for the DAC. It must be sufficient to obtain a reproducible measurement, but it means turning on the RF driver, which consumes the most energy. The SwingCnt parameter value is defined in the Idle command and is usually set to 0x3F.

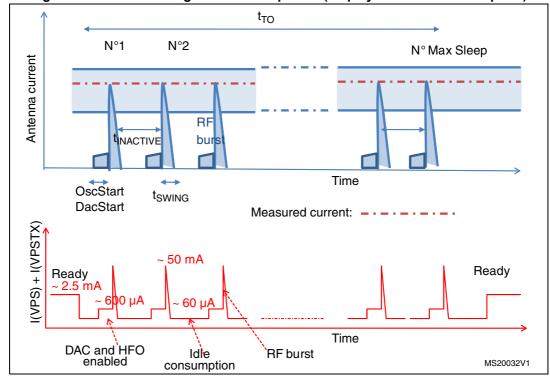


Figure 9 illustrates a time-limited tag detection sequence where no tag is present in the operating volume, none is detected and the device wakes up after a timeout. The lower part of the figure illustrates the power consumption profile.

A basic Idle command used for a time-limited tag detection sequence is:

>>> 0x 07 0E 0B 21 00 79 01 18 00 20 60 60 54 64 3F 08

Figure 9. Time-limited tag detection sequence (display of device consumption)





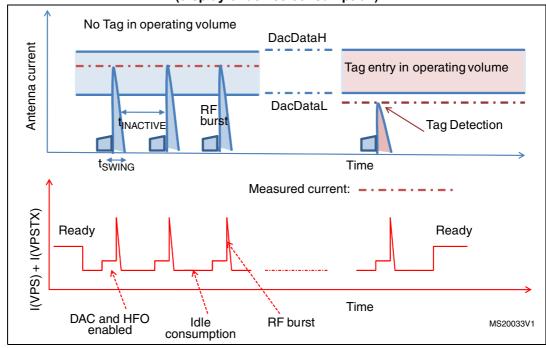
AN3433 Rev 3 27/37

Figure 10 illustrates an unlimited tag detection sequence interrupted by a tag entering the device operating volume. The lower part of the figure illustrates the power consumption profile during tag detection and after the device automatically returns to Ready state.

A basic Idle command used for an unlimited tag detection sequence is:

>>> 0x 07 0E 0A 21 00 79 01 18 00 20 60 60 54 64 3F 08

Figure 10. Tag detection sequence, Wakeup after tag entry in operating volume (display of device consumption)



28/37 AN3433 Rev 3

Appendix B Tag detection calibration process

The Tag detection calibration process must be performed when the application is initialized.

A fast and efficient dichotomous flow in eight steps is proposed to achieve best results.

Before starting this flow, the user must define its basic setup, which consists in defining parameters (described in *Section 2.3*) using the Idle command.

When using the device demonstration board and development kit, the following values are recommended:

- Wakeup condition: 0x03 (tag detection or timeout)
- EnterCtrlL/EnterCtrlH, WUCtrlL/WUCtrlH, and LeaveCtlL/LeaveCtrlH values define internal parameters settings during the tag detection process. It is recommended:

```
>>> 0xA1 00 F8 01 18 00
```

- MaxSleep: MUST be set to '01' in Tag detection calibration process for immediate
 wakeup. This means that only one detection impulse will be sent and immediately
 afterwards the device will exit Tag detection calibration mode.
- Oscillator and DAC stabilization times. It is recommended 0x60.
- Number of 13.56 MHz swings during tag detection (SwingsCnt), it is recommend to use 0x3F to obtain a good reproducibility of measurements.
- WakeUp period. This parameter is not used during the Tag detection calibration process.
- The Host can then use the RdReg command to read the Wakeup condition register to determine the cause of the wakeup or check the reply code.

A basic Tag detection calibration command is:

```
>>> 0x 07 0E 03 A1 00 F8 01 18 00 20 60 60 00 xx 3F 01
```

B.1 Tag detection calibration algorithm

To determine the RF Field reference level (CalRef) corresponding to your application setup, you must use the Tag detection calibration function (TagCal).

For calibration purposes, parameters are set to execute only one RF field evaluation before leaving Tag Detection state.

This is achieved by setting the WU condition parameter to 0x03 (wakeup upon timeout or tag detection) and the MaxSleep value to 0x01 forcing the device to leave the Tag Detection state after only one attempt.

The value of the Wakeup flag is updated to the following value each time the device leaves Tag Detection state.

Here, the ${\tt WakeUp_n}$ variable corresponds to the third byte of the device Idle command reply.

If the measured antenna current is between DacDataL and DacDataH, the wakeup event will be a timeout: $WakeUp_n = 1$

If the measured antenna current is less than DacDataL or greater than DacDataH, the wakeup event will be a tag detection: WakeUp n = 2

4

AN3433 Rev 3 29/37

During the calibration process, DacDataL is set to 0x00 and the reference level is determined changing only the DacDataH parameter.

The reference level corresponds to the switching level between wakeup sources. It is determined using the fast dichotomous process in eight steps;

The Tag detection calibration command is formatted as follows:

```
TagCal(Ref H) = 0 \times 07 0E 03 A1 00 F8 01 18 00 20 60 60 00 Ref_H 3F 01
```

All the parameters are predefined to fit applicative requests in terms of wakeup sources and power consumption, a bargain must be struck between detection period and power consumption.

TagDet (64,74, or DacDataL and DacDataH, respectively) is defined using the command:

```
>>> 0x07 0E 0B 21 00 79 01 18 00 20 60 60 64 74 3F 00
```

B.2 Tag detection calibration command

The Tag detection calibration command (TagCal) is a special setting of the Tag detection command (TagDet) for which the only variable is Ref_H.

```
>>> 0x07 0E 03 A1 00 F8 01 18 00 01 60 60 00 XX 3F 00 <<< 0x00 01 01 (in the event of a timeout) or <>< 0x00 01 02 (in the event of a tag detection in the RF field)
```

Here, the third byte (the WakeUp_n variable) defines the Wakeup event.

It is also possible to directly use the Wakeup Flag command: $0 \times 08 \ 03 \ 62 \ 01 \ 00$

Read Wakeup Flag reply:

```
    In case of timeout: 0x00 01 01 (WakeUp_n = 0x01)
    In case of Tag Detection: 0x00 01 02 (WakeUp_n = 0x02)
```

In Figure 11, the function TagCal (0xRef_n) corresponds to the execution of the following device Idle command:

```
>>> 0x07 0E 03 A1 00 F8 01 18 00 20 60 60 00 0xRef_n 3F 01 <<< 0x00 01 01 (in the event of a timeout) or <<< 0x00 01 02 (in the event of a tag detection in the RF field)
```

Here, the third byte (the **wakeUp_n** variable) defines the Wakeup event.

30/37 AN3433 Rev 3

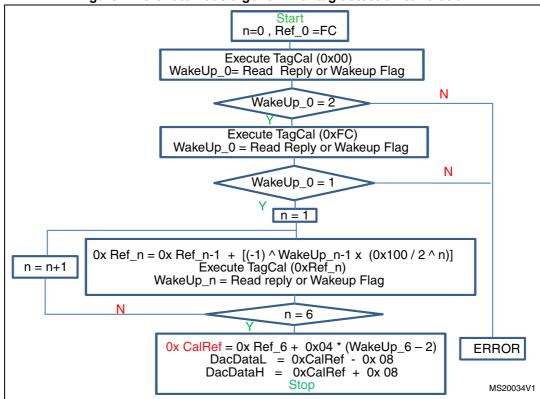


Figure 11. dichotomous algorithm for tag detection calibration

57

AN3433 Rev 3 31/37

Appendix C Example of tag detection calibration process

This process is a dichotomous approach to quickly converge to the DacDataRef value for which a wakeup event switches from tag detection to timeout. In this process, only the DacDataH parameter is changed in successive Idle commands. User needs to look at the wakeup event reply to decide the next step.

```
<<< 00 01 02 corresponds to a Tag Detection (WakeUp_n = 2)
<<< 00 01 01 corresponds to a Timeout (WakeUp_n = 1)
REM, Tag detection calibration Test
       Sequence: Power-up Tag Detect Wake-up by Tag Detect (1 try
REM.
measurement greater or equal to DacDataH) or Timeout
       CMD 07 0E 03 A100 F801 1800 20 60 60 00 XX 3F 01
REM,
            WU source = TagDet or Timeout
REM.
REM,
       A100 Initial Dac Compare
REM.
       F801 Initial Dac Compare
       1800 HFO
REM,
       20 WuPeriod = 32, Inactivity period = 256ms (LFO @ 32kHz)
REM,
       60 Osc
                     (LFO @ 32kHz)
REM.
              3ms
REM,
       60 Dac
              3ms
                     (LFO @ 32kHz)
REM.
       0.0
          DacDataL = minimum level (floor)
          DacDataH 00 = minimum level (ceiling)
REM,
          Swing 13.56 4.6 us
REM,
REM.
       01 Maximum number of Sleep before Wakeup 2
REM, Tag Detection Calibration Test
REM, During Tag Detection Calibration process DacDataL = 0x00
REM, We execute several tag detection commands with different
DacDataH values to determine DacDataRef level corresponding to
CR95HF application set-up
REM, DacDataReg value corresponds to DacDataH value for which Wake-
up event switches from Timeout (0x01) to Tag Detect (0x02)
REM, Wake-up event = Timeout when DacDataRef is between DacDataL
and DacDataH
REM, Search DacDataref value corresponding to value of DacDataH for
which Wake-up event switches from Tag Detect (0x02) to Timeout
(0x01)
```

32/37 AN3433 Rev 3

```
REM, Step 0: force wake-up event to Tag Detect (set DacDataH = 0x00)
REM, With these conditions Wake-Up event must be Tag Detect
>>> CR95HFDLL STCMD, 01 070E03A100F801180020606000003F01
<<< 00 01 02
REM, Read Wake-up event = Tag Detect (0x02); if not, error.
REM, Step 1: force Wake-up event to Timeout (set DacDataH = 0xFC
REM, With these conditions, Wake-Up event must be Timeout
>>> CR95HFDLL_STCMD, 01 070E03A100F801180020606000FC3F01
<<< 00 01 01
REM, Read Wake-up event = Timeout (0x01); if not, error.
REM, Step 2: new DacDataH value = previous DacDataH +/- 0x80
REM, If previous Wake-up event was Timeout (0x01) we must decrease
DacDataH (-0x80)
>>> CR95HFDLL_STCMD, 01 070E03A100F8011800206060007C3F01
<<< 00 01 01
REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag
Detect (0x02)
REM, Step 3: new DacDataH value = previous DacDataH +/- 0x40
REM, If previous Wake-up event was Timeout (0x01), we must decrease
DacDataH (-0x40); else, we increase DacDataH (+ 0x40)
>>> CR95HFDLL_STCMD, 01 070E03A100F8011800206060003C3F01
<<< 00 01 02
REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag
Detect (0x02)
REM, Step 4: new DacDataH value = previous DacDataH +/- 0x20
REM, If previous Wake-up event was Timeout (0x01), we must decrease
DacDataH (-0x20); else, we increase DacDataH (+0x20)
>>> CR95HFDLL_STCMD, 01 070E03A100F8011800206060005C3F01
<<< 00 01 02
REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag
Detect (0x02)
REM, Step 5: new DacDataH value = previous DacDataH +/- 0x10
```

AN3433 Rev 3 33/37

REM, If previous Wake-up event was Timeout (0x01), we must decrease DacdataH (-0x10); else, we increase DacDataH (+0x10)

>>> CR95HFDLL_STCMD, 01 070E03A100F801180020606000**6C**3F01

<<< 00 01 **02**

REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag Detect (0x02)

REM, Step 6: new DacDataH value = previous DacDataH +/- 0x08

REM, If previous Wake-up event was Timeout (0x01), we must decrease DacDataH (-0x08); else, we increase DacDataH (+0x08)

>>> CR95HFDLL_STCMD, 01 070E03A100F801180020606000743F01

<<< 00 01 **01**

REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag Detect (0x02)

REM, Step 7: new DacDataH value = previous DacDataH +/- 0x04

REM, If previous Wake-up event was Timeout (0x01), we must decrease DacDataH (-0x04); else, we increase DacDataH (+0x04)

>>> CR95HFDLL STCMD, 0 1070E03A100F801180020606000**70**3F01

<<< 00 01 **01**

REM, Read Wake-up event = Timeout (0x01) or Wake-up event = Tag Detect (0x02)

REM, If last Wake-up event = Tag Detect (0x02), search DacDataRef = last DacDataH value

REM, If last Wake-up event = Timeout (0x01), search DacDataRef = last DacDataH value -4

REM, For tag detection usage, we recommend setting DacDataL = DacDataRef -8 and DacDataH = DacDataRef +8

>>> CR95HFDLL_STCMD, 01 070E0B210079011800206060**6474**3F01

<<< 00 01 **01**



Appendix D Example of Tag detection command using results of Tag detection calibration

This is an example of a Tag Detection command when a tag is not present in the RF operating volume:

This is an example of a Tag Detection command when a tag is present in the RF operating volume:



Revision history AN3433

Revision history

Table 8. Document revision history

Date	Revision	Changes
05-Dec-2011	1	Initial release.
23-Feb-2012	2	Updated the document throughout to include the STRFNFCA device.
07-Jan-2019	3	Added ST25R95 device and removed STRFNFCA device. Updated document title, Introduction, Section 2.4: Using LFO frequency settings to reduce power consumption, Section 2.5.1: Wakeup source register, Section 3.2: Transition from Ready to Sleep state, Appendix C: Example of tag detection calibration process and Appendix D: Example of Tag detection command using results of Tag detection calibration. Minor text edits and adjustments across the whole document Updated Table 2: List of characteristic values, Table 3: ST25R95 and CR95HF operating modes and states, Table 4: Idle command description and Table 6: Summary of parameters. Added Table 7: Enter, WU, and Leave Control resource configuration.

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AN3433 Rev 3 37/37